

Notice of References Cited	Application/Control No. 10/054,400	Applicant(s)/Patent Under Reexamination KIM ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Brouwer et al., An updated table of minimum-distance bounds for binary linear codes, 3-1993, IEEE Trans. on Info. Theory, Vol. 39, No. 2, pg. 662-677.
	V	Samsung Electronics Co., Ltd., Dynamic split mode for TFCl, 11-2000, TSG-RAN Working Group 1 meeting #17, TSGR1#17(00)1269, pg. 1-5.
	W	Samsung, Test proposal regrading TFCl coding for TDD, 9-1999, TSG-RAN Working Group1 neeting #7, TSRG1#7 (99)b61, pg. 1-4.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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